Monitoring Architectures for RTP

draft-ietf-avtcore-monarch-06

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Overview

Background

- 03 version discussed in Quebec meeting.
- 04,05 version received comments on the list from Magnus, Colin and Cao Ning.
- 06version contains update reflect that discussion

What it is about

- Discuss two component of RTP monitoring architecture
- Provide 3 guidelines on how to define XR Block
- Discuss RFC 5117 topologies applicability issue

Changes since 03 version in last meeting

- Update section 5.2 to clarify using SDES packet to carry correlation information.
- Replace "chunk" with "new SDES item".
- Add texts in security section to discussion potential security issues.
- Add new section 5.3 to discuss Reducing Measurement information repetition.
- Reference update by adding document title
- Other editorial changes.

Comment on measurement information repetition

- Is there a recommendation for measurement information duplication?
 - Comments from Magnus's review recently
 - Clarification (has been implemented in the new version):
 - distinguish the identity information with measurement information.
 - Define new SDES item to carry Identity information like application specific identifier
 - Define new XR Block to carry measurement information like measurement period.

Comment on security section

- Is there Security issue with Monitoring(e.g., privacy and leaking information)?
 - Comment from Magnus's review
 - Action (has been implemented in the document)
 - Introduce no security vulnerabilities beyond those described in RTCP XRs [RFC3611].
 - security issues with monitoring
 - Forwarding monitoring report to other translator present security risk
 - Third party monitors involvement present security risk.

Comment on sample metric

- Suggest to add definitions for additional terms, including interval metric, cumulative metric, and sampled metric
 - Reasonable
 - Proposed definitions as follows(already implemented)

Sample Metrics:

It is referred to as the metrics of which the reported values only apply the value of a continuously measured or calculated that has been sampled at end of the interval .

Interval metrics:

It is referred to as the metrics of which the reported values apply to the most recent measurement interval duration between successive metrics reports.

Cumulative metrics

It is referred to as the metrics of which the reported values apply to the accumulation period characteristic of cumulative measurements.

Follow Up

• WGLC?